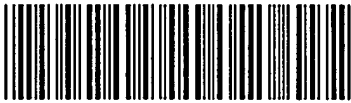


Search Notes

Application/Control No.

10/616,234

Examiner

Long K. Tran

Applicant(s)/Patent under
Reexamination

BANISCH ET AL.

Art Unit

2818

SEARCHED

Class	Subclass	Date	Examiner
257	209,529	2/10/2005	LKT
257	758	2/10/2005	LKT
438	118,623	2/10/2005	LKT
438	128,129	2/10/2005	LKT
438	132,215	2/10/2005	LKT
438	281,333	2/10/2005	LKT
438	601	2/10/2005	LKT
327	525	2/11/2005	LKT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257	529,209	2/10/2005	LKT
257	758	2/10/2005	LKT
438	281,333	2/10/2005	LKT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Searched	2/10/2005	LKT
EAST Searched	2/11/2005	LKT